



PATENT

Case Docket No. HEIWA.017AUS
Date: May 1, 2006

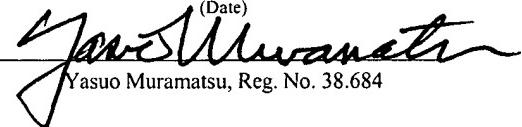
IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicant(s) : Hideyuki Oshima
Appl. No. : 10/507,042
Filed : September 7, 2004
For : SEMICONDUCTOR TEST APPARATUS
Group Art Unit : 2829
Batch No. :
Examiner : Tang, Minh Nhut

I hereby certify that this correspondence and all marked attachments are being deposited with the United States Postal Service as first class mail in an envelope addressed to: Commissioner for Patents, P. O. Box 1450, Alexandria, VA 22313-1450 on

May 1, 2006

(Date)



Yasuo Muramatsu, Reg. No. 38,684

TRANSMITTAL LETTER

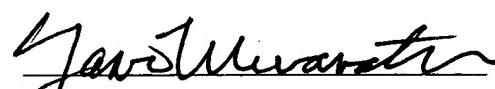
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ATTENTION: OFFICE OF PATENT PUBLICATIONS

Dear Sir:

Enclosed for filing is the Issue Fee for the above-identified application:

- (X) Form PTOL-85b.
(X) A check in the amount of \$1,715.00 to cover the issue fee is enclosed.
(X) Return prepaid postcard.



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